

INFORMATION DISCLOSURE STATEMENT	Case No.	Gammel 18-47-1-57
	Serial No.	09/651,696
	Applicant:	P.L. Gammel, et al.
	Filing Date:	
	Group:	2879

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date
ab	AA	5,637,539	06/10/97	Hofmann et al.	438	—	01/16/96
	AB	5,955,828	09/21/99	Sadwick et al.	313	—	10/16/97
	AC	6,027,951	02/22/00	MacDonald et al	438	—	08/18/98
	AD	5,363,021	11/08/94	MacDonald	316	—	07/12/93
	AE	5,536,988	07/16/96	Zhang et al.	310	—	06/01/93
ab	AF	6,034,810	03/07/00	Robinson et al.	359	—	10/15/98

OTHER (including Author, Title, Date, Pertinent Pages, etc.)

	AR	A.S. Gilmour, Jr., Microwave Tubes, Artech House, pp. 191-313 (1986).
ab	AS	I. Brodie, et al., "Vacuum microelectronics", <u>Advances in Electronics and Electron Physics</u> , Vol. 83 (1992).
	AT	Ren et al. <u>Science</u> , Vol. 282, 1105 (1998)
	AU	Fan et al., <u>Science</u> , Vol. 283, 512 (1999)
	AV	Rinzler et al., <u>Science</u> , Vol. 269, 1550 (1995)
	AW	De Heer et al., <u>Science</u> , Vol. 270, 1179 (1995)
	AX	Saito et al., <u>Jpn. J. Appl. Phys.</u> , Vol. 37, L346 (1998).
	AY	Wang et al., <u>Appl. Phys. Lett.</u> , Vol. 72, 2912 (1998)
	AZ	Bonard et al., <u>Appl. Phys. Lett.</u> , Vol. 73, 918 (1998).
	BA	D.A. Koester, et al. MUMPs™ Design Handbook, Rev. 5.0
ab	BB	D.K. Lynn, et al., "Thermionic Integrated Circuits: Electronics For Hostile Environments", <u>IEEE Transactions on Nuclear Science</u> , Vol. NS-32, No. 6 (1985)
	BC	U.S. Patent Application Serial No. 09/236966 filed on January 25, 1999
	BD	U.S. Patent Application Serial No. 09/236933 filed on January 25, 1999
	BE	U.S. Patent Application Serial No. 09/296572 filed on April 22, 1999
	BF	U.S. Patent Application Serial No. 09/351537 filed on July 12, 1999
	BG	U.S. Patent Application Serial No. 09/512873 filed on February 25, 2000
	BH	U.S. Patent Application Serial No. 09/376457 filed on August 18, 1999

EXAMINER <i>Ab</i>	DATE CONSIDERED 3/21/04
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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609: Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

INFORMATION DISCLOSURE STATEMENT	Case No.	Gammel 18-47-1-57
	Serial No.	09/651, 696
	Applicant:	P.L. Gammel, et al.
	Filing Date:	August 30, 2000
	Group:	2879

OTHER (including Author, Title, Date, Pertinent Pages, etc.)		
<i>al</i>	AR	Green, R. et al., "Vacuum Integrated Circuits", <i>IEDM 85</i> , pp. 172-175



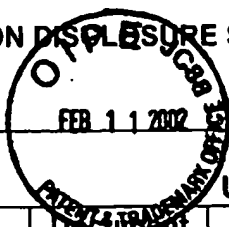
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EXAMINER <i>Ash</i>	DATE CONSIDERED 3/21/04
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INFORMATION DISCLOSURE STATEMENT

Case Name. P.L. Gammel 18-47-1-57
 Serial No. 09/651696
 Applicant: P.L. Gammel, et al.
 Filing Date: August 30, 2000
 Group: 2879



U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation
<i>al</i>	AG EP0880077A2	5/5/98	Europe	G03F	9/00	...
<i>al</i>	AH WO98/44529	10/8/98	International	H01J	9/02	...

OTHER (including Author, Title, Date, Pertinent Pages, etc.)

<i>al</i>	AI	Iannazzo, S., "A Survey Of The Present Status Of Vacuum Microelectronics", Solid-State Electronics, Vol. 36, No. 3, pages 301-320, March 1, 1993.

***References listed beyond AZ would list as AA-1, AB-2, AC-3 thru AZ-26.

***Note First Page ONLY Header/Footer. Subsequent pages must ONLY have page # layout as header

EXAMINER <i>Ashtu</i>	DATE CONSIDERED <i>3/21/04</i>
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